M. Flom Associates, Inc. - Global Compliance Center
3356 North San Marcos Place, Suite 107, Chandler, Arizona 85225-7176
www.mflom.com info@mflom.com (480) 926-3100, FAX: 926-3598

Transmitter Certification

of

FCC ID: ALH35733110
Model: TK-5210-K, TK-5210-K2, TK-5210-K3

to

Federal Communications Commission

Rule Part(s) 22, 74, 90, 90.210, Confidentiality

Date of report: May 21, 2004

On the Behalf of the Applicant:

Kenwood USA Corporation

At the Request of:

P.O. JB-F-006

Kenwood USA Corporation
Communications Division
3975 Johns Creek Court, Suite 300
Suwanee, GA 30024

Attention of: Joel E. Berger, Research & Development
JBerger@kenwoodusa.com
(678) 474-4722; FAX: -4731

Supervised by: Morton Flom, P. Eng.

List of Exhibits

(FCC **Certification** (Transmitters) - Revised 9/28/98)

Applicant: Kenwood USA Corporation

FCC ID: ALH35733110

By Applicant:

1. Letter of Authorization	x
2. Confidentiality Request: 0.457 And 0.459	x
3. Part 90.203(e) & (g) Attestation	x
4. Identification Drawings, 2.1033(c)(11)	
x Label	
x Location of Label	
x Compliance Statement	
x Location of Compliance Statement	
5. Photographs, 2.1033(c)(12)	x
6. Documentation: 2.1033(c)	
(3) User Manual	x
(9) Tune Up Info	x
(10) Schematic Diagram	x
(10) Circuit Description	x
Block Diagram	x
Parts List	x
Active Devices	x
7. SAR Attestation	x

By M.F.A. Inc.:

A. Testimonial & Statement of Certification

The Applicant has been cautioned as to the following:

15.21 **Information to the User**.

The users manual or instruction manual for an intentional radiator shall caution the user that changes or modifications not expressly approved by the party responsible for compliance could void the user's authority to operate the equipment.

15.27(a) **Special Accessories**.

Equipment marketed to a consumer must be capable of complying with the necessary regulations in the configuration in which the equipment is marketed. Where special accessories, such as shielded cables and/or special connectors are required to enable an unintentional or intentional radiator to comply with the emission limits in this part, the equipment must be marketed with, i.e. shipped and sold with, those special accessories. However, in lieu of shipping or packaging the special accessories with the unintentional or intentional radiator, the responsible party may employ other methods of ensuring that the special accessories are provided to the consumer, without additional charge.

Information detailing any alternative method used to supply the special accessories for a grant of equipment authorization or retained in the verification records, as appropriate. The party responsible for the equipment, as detailed in § 2.909 of this chapter, shall ensure that these special accessories are provided with the equipment. The instruction manual for such devices shall include appropriate instructions on the first page of text concerned with the installation of the device that these special accessories must be used with the device. It is the responsibility of the user to use the needed special accessories supplied with the equipment.

Table of Contents

Required information per ISO/IEC Guide 25-1990, paragraph 13.2:

a) **Test Report**

b) Laboratory: M. Flom Associates, Inc.
(FCC: 31040/SIT) 3356 N. San Marcos Place, Suite 107
(Canada: IC 2044) Chandler, AZ 85225

c) Report Number: d0450043

d) Client: Kenwood USA Corporation
Communications Division
3975 Johns Creek Court, Suite 300
Suwanee, GA 30024

e) Identification: TK-5210-K, TK-5210-K2, TK-5210-K3
FCC ID: ALH35733110
S/N: 40, 41
EUT Description: VHF FM Handheld Transceiver

f) EUT Condition: Not required unless specified in individual tests.

g) Report Date: May 21, 2004
EUT Received: 2004-Apr-27

h, j, k): As indicated in individual tests.

i) Sampling method: No sampling procedure used.

l) Uncertainty: In accordance with MFA internal quality manual.

m) Supervised by:

Morton Flom, P. Eng.

n) Results: The results presented in this report relate only to the item tested.

o) Reproduction: This report must not be reproduced, except in full, without written permission from this laboratory.

Page Number 2 of 46.

Sub-part 2.1033(c)(14): **Test and Measurement Data**

All tests and measurement data shown were performed in accordance with FCC Rules and Regulations, Volume II; Part 2, Sub-part J, Sections 2.947, 2.1033(c), 2.1041, 2.1046, 2.1047, 2.1079, 2.1051, 2.1053, 2.1055, 2.1057 and the following individual Parts:

____ 21 – Domestic Public Fixed Radio Services
x 22 – Public Mobile Services
____ 22 Subpart H - Cellular Radiotelephone Service
____ 22.901(d) - Alternative technologies and auxiliary services
____ 23 – International Fixed Public Radiocommunication services
____ 24 – Personal Communications Services
x 74 Subpart H - Low Power Auxiliary Stations
____ 80 – Stations in the Maritime Services
____ 80 Subpart E - General Technical Standards
____ 80 Subpart F - Equipment Authorization for Compulsory Ships
____ 80 Subpart K - Private Coast Stations and Marine Utility Stations
____ 80 Subpart S - Compulsory Radiotelephone Installations for Small Passenger Boats
____ 80 Subpart T - Radiotelephone Installation Required for Vessels on the Great Lakes
____ 80 Subpart U - Radiotelephone Installations Required by the Bridge-to-Bridge Act
____ 80 Subpart V - Emergency Position Indicating Radio Beacons (EPIRB'S)
____ 80 Subpart W - Global Maritime Distress and Safety System (GMDSS)
____ 80 Subpart X - Voluntary Radio Installations
____ 87 – Aviation Services
x 90 – Private Land Mobile Radio Services
____ 94 – Private Operational-Fixed Microwave Service
____ 95 Subpart A - General Mobile Radio Service (GMRS)
____ 95 Subpart C - Radio Control (R/C) Radio Service
____ 95 Subpart D - Citizens Band (CB) Radio Service
____ 95 Subpart E - Family Radio Service
____ 95 Subpart F - Interactive Video and Data Service (IVDS)
____ 97 - Amateur Radio Service
____ 101 – Fixed Microwave Services

Standard Test Conditions
and
Engineering Practices

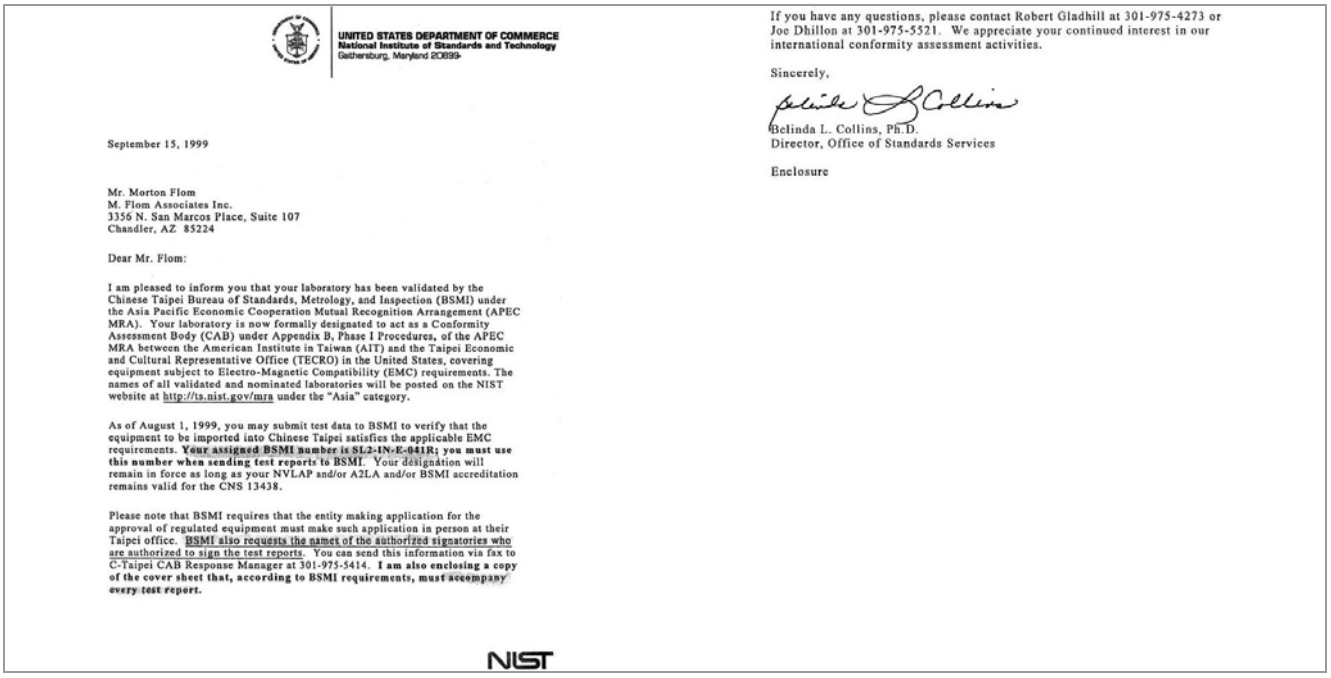
Except as noted herein, the following conditions and procedures were observed during the testing:

In accordance with ANSI C63.4-1992/2000 Draft, section 6.1.9, and unless otherwise indicated in the specific measurement results, the ambient temperature of the actual EUT was maintained within the range of 10° to 40°C (50° to 104 °F) unless the particular equipment requirements specify testing over a different temperature range. Also, unless otherwise indicated, the humidity levels were in the range of 10% to 90% relative humidity.

Prior to testing, the EUT was tuned up in accordance with the manufacturer's alignment procedures. All external gain controls were maintained at the position of maximum and/or optimum gain throughout the testing.

Measurement results, unless otherwise noted, are worst-case measurements.

NIST



UNITED STATES DEPARTMENT OF COMMERCE
National Institute of Standards and Technology
Gaithersburg, Maryland 20899-

September 15, 1999

Mr. Morton Flom
M. Flom Associates Inc.
3356 N. San Marcos Place, Suite 107
Chandler, AZ 85224

Dear Mr. Flom:

I am pleased to inform you that your laboratory has been validated by the Chinese Taipei Bureau of Standards, Metrology, and Inspection (BSMI) under the Asia Pacific Economic Cooperation Mutual Recognition Arrangement (APEC MRA). Your laboratory is now formally designated to act as a Conformity Assessment Body (CAB) under Appendix B, Phase I Procedures, of the APEC MRA between the American Institute in Taiwan (AIT) and the Taipei Economic and Cultural Representative Office (TECRO) in the United States, covering equipment subject to Electro-Magnetic Compatibility (EMC) requirements. The names of all validated and nominated laboratories will be posted on the NIST website at http://ts.nist.gov/mra under the "Asia" category.

As of August 1, 1999, you may submit test data to BSMI to verify that the equipment to be imported into Chinese Taipei satisfies the applicable EMC requirements. **Your assigned BSMI number is SL2-IN-E-041R; you must use this number when sending test reports to BSMI.** Your designation will remain in force as long as your NVLAP and/or A2LA and/or BSMI accreditation remains valid for the CNS 13438.

Please note that BSMI requires that the entity making application for the approval of regulated equipment must make such application in person at their Taipei office. BSMI also requests the names of the authorized signatories who are authorized to sign the test reports. You can send this information via fax to C-Taipei CAB Response Manager at 301-975-5414. **I am also enclosing a copy of the cover sheet that, according to BSMI requirements, must accompany every test report.**

If you have any questions, please contact Robert Gladhill at 301-975-4273 or Joe Dhillon at 301-975-5521. We appreciate your continued interest in our international conformity assessment activities.

Sincerely,

Belinda L. Collins, Ph.D.
Director, Office of Standards Services

Enclosure

NIST

Industry Canada

Industry Canada
Industrie Canada

Certification and Engineering Bureau

M. Flom Associates Inc.

is recognized as an approved testing facility, in accordance with the provisions of the Industry Canada Terminal Attachment Programme, subject to any exclusions specified in their letter of approval.

Director, Certification and Engineering Bureau

Canada

Industrie Canada Industry Canada
Certification and Engineering Bureau
1241 Clyde Avenue
Ottawa, Ontario
K2C 1Y3

Tel. No. (613) 952-3650
Fax. No. (613) 952-1088

February 24, 1998

Our File: 46327- 2044
Submission: 19320 O

Mr. M. Flom
M. Flom Associates, Inc.
3356 North San Marcos Place, Suite 107
Chandler, Arizona 85224-1571

Dear Mr. Flom,

The Bureau has received your test report for the Open Area Test Site located at Chandler, Arizona, dated January 30, 1998 and the supplemental information received February 24, 1998. I have reviewed the report and find it complies with RSP 100, Issue 7, section 3.3 Description of Open Area Test Site.

The site is acceptable to Industry Canada for the performance of radiated measurements. Please reference the file number " IC 2044 " in the body of all test reports containing measurements made on this site. This reference number is the indication of Industry Canada's acceptance of your site. Your company has been added to our published list of qualified sites on the Bureau's web page. It is located at: http://spectrum.ic.gc.ca/~cert/ Please keep the contact information current by notifying us if it changes or is in error.

Keep informed of the latest Industry Canada regulations by visiting the Bureau's site on the World Wide Web;

http://spectrum.ic.gc.ca/~cert/
or the Industry Canada main site at;
http://strategis.ic.gc.ca

Whenever major construction or repairs to the site are completed, a re-submission of the site attenuation characteristics will be required.

Yours sincerely,

Brian Kasper

Brian Kasper
Head, EMC and Standards
Certification and Engineering Bureau

Canada

List of General Information Required for Certification

In Accordance with FCC Rules and Regulations,
Volume II, Part 2 and to

22, 74, 90, 90.210, Confidentiality

Sub-part 2.1033

(c)(1): **Name and Address of Applicant**:

Kenwood USA Corporation
Communications Division
3975 Johns Creek Court, Suite 300
Suwanee, GA 30024

Manufacturer:

Kenwood Electronics Technologies PTE Ltd.
1 Ang Mo Kio Street 63
Singapore 569110

(c)(2): **FCC ID**: ALH35733110

Model Number: TK-5210-K, TK-5210-K2, TK-5210-K3

(c)(3): **Instruction Manual(s):**

Please see attached exhibits

(c)(4): **Type of Emission**: 16K0F3E, 11K0F3E, 8K10F1E, 8K10F1D

(c)(5): **Frequency Range, MHz**: 136.00 to 174.00

(c)(6): **Power Rating, Watts**: 5.0

____ Switchable x Variable ____ N/A

FCC Grant Note: BB - Power output continuously variable from value listed to less than 0.5 watts.

(c)(7): **Maximum Power Rating, Watts**: 300

DUT Results: Passes x Fails _____

Information for Push-To-Talk Devices

Type and number of antenna to be used for this device:
Whip antennas for use on transceiver and on remote speaker microphone

Maximum antenna gain for antenna indicated above:
0dBi

Can this device sustain continuous operation with respect to its hardware capabilities and allowable operating functions?
No

Other hardware or operating restrictions that could limit a person's RF Exposure:
Time-Out-Timer

Source-based time-averaging (see 2.1093 of rules) applicable to reduce the average output power:
No

If device has headset and belt-clip accessories that would allow body-worn operations, what is the minimum separation distance between the antenna and the user's body in this operating configuration?
2.5cm

Can device access wire-line services to make phone calls, either directly or through an operator?
No

Can specific operating instructions be given to users to eliminate any potential RF Exposure concerns for both front-of-the-face and body-worn operating configurations?
Yes, included in User Manual

Other applicable information the applicant may provide that can serve as effective means for ensuring RF Exposure compliance:
See User Manual

Page Number 7 of 46.

Subpart 2.1033 (continued)
(c)(8): Voltages & currents in all elements in final RF stage, including final transistor or solid-state device:

Collector Current, A	=	per manual
Collector Voltage, Vdc	=	per manual
Supply Voltage, Vdc	=	7.5

(c)(9): **Tune-Up Procedure**:

Please see attached exhibits

(c)(10): **Circuit Diagram/Circuit Description**:
Including description of circuitry & devices provided for determining and stabilizing frequency, for suppression of spurious radiation, for limiting modulation and limiting power.

Please see attached exhibits

(c)(11): **Label Information**:

Please see attached exhibits

(c)(12): **Photographs**:

Please see attached exhibits

(c)(13): **Digital Modulation Description**:

___ Attached Exhibits
_x_ N/A

(c)(14): **Test and Measurement Data**:

Follows

Page Number 8 of 46.

Name of Test: Carrier Output Power (Conducted)

Specification: 47 CFR 2.1046(a)

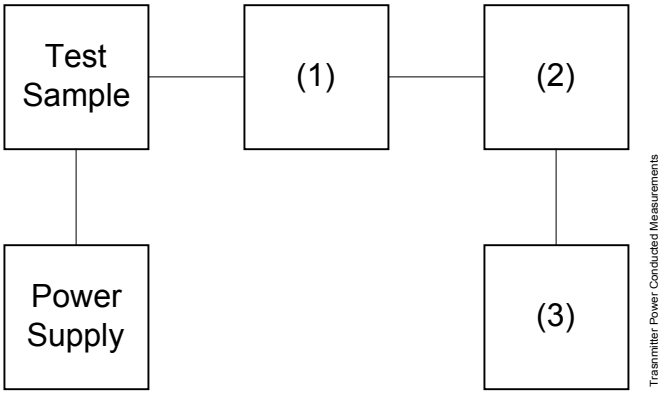
Guide: ANSI/TIA/EIA-603-1992, Paragraph 2.2.1

Measurement Procedure

A) The EUT was connected to a resistive coaxial attenuator of normal load impedance, and the unmodulated output power was measured by means of an RF Power Meter.

B) Measurement accuracy is ±3%.

Transmitter Test Set-Up: RF Power Output



	Asset	Description	s/n
(1)	**Coaxial Attenuator**		
X	i00231/2	PASTERNACK PE7021-30 (30 dB)	231 or 232
	i00122/3	NARDA 766 (10 dB)	7802 or 7802A
(2)	**Power Meters**		
X	i00020	HP 8901A Power Mode	2105A01087
(3)	**Frequency Counter**		
X	i00020	HP 8901A Frequency Mode	2105A01087

Measurement Results
(Worst case)

Frequency of Carrier, MHz = 136.000, 155.000, 173.950
Ambient Temperature = 23°C ± 3°C

Power Setting	dBm	RF Power, Watts
High	6.99dBm + 30dB Attenuator = 36.99	5.0

Performed by: David E. Lee, Lab Manager

Page Number 10 of 46.

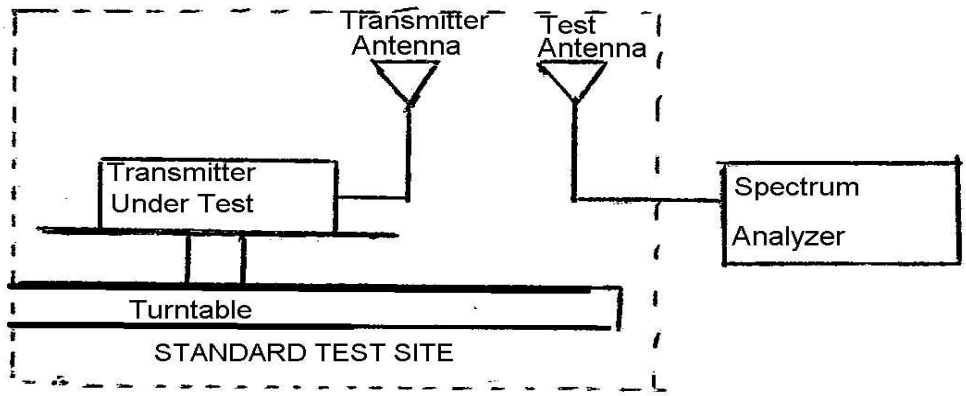
Name of Test: ERP Carrier Power (Radiated)

Specification: TIA/EIA 603A (Substitution Method)

Measurement Procedure

Definition
The average radiated power of a licensed device is the equivalent power required, when delivered to a half-wave dipole or horn antenna, to produce at a distant point the same average received power as produced by the licensed device.

Method of Measurement:
A) Connect the equipment as illustrated. Place the transmitter to be tested on the turntable in the standard test site.



B) Raise and lower the test antenna from 1m to 6 m with the transmitter facing the antenna and record the highest received signal in dB as LVL.

C) Repeat step B) for seven additional readings at 45° interval positions of the turntable.

D) Replace the transmitter under test with a half-wave or horn vertically polarized antenna. The center of the antenna should be at the same location as the transmitter under test. Connect the antenna to a signal generator with a known output power and record the path loss in dB or LOSS.

E) Calculate the average radiated output power from the readings in step C) and D) by the following:

$$\textbf{average radiated power} = 10 \log_{10} \Sigma\, 10^{(LVL - LOSS)/10} \text{ (dBm)}$$

Test Equipment

	Asset	Description	s/n	Cycle	Last Cal
Transducer					
X	i00088	EMCO 3109-B 25MHz-300MHz	2336	12 mo.	Sep-03
X	i00089	Aprel 2001 200MHz-1GHz	001500	12 mo.	Sep-03
X	i00103	EMCO 3115 1GHz-18GHz	9208-3925	12 mo.	Jan-03
Amplifier					
	i00028	HP 8449A	2749A00121	12 mo.	May-03
Spectrum Analyzer					
	i00029	HP 8563E	3213A00104	12 mo.	May-03
X	i00033	HP 85462A	3625A00357	12 mo.	Aug-03
Substitution Generator					
X	i00067	HP 8920A Communication TS	3345U01242	12 mo.	Oct-03
	i00207	HP 8753D Network Analyzer	3410A08514	12 mo.	Jul-03

Measurement Results

	136.000 MHz		164.500 MHz		173.950 MHz	
	LVL, dBm	Path Loss, dB	LVL, dBm	Path Loss, dB	LVL, dBm	Path Loss, dB
0°	21.4		17.3		19.4	
45°	12.0		27.3		18.6	
90°	6.6		24.9		16.1	
135°	11.0	+0.3	20.5	-2.2	24.4	+0.7
180°	19.2		16.9		22.8	
225°	22.7		23.3		10.2	
270°	14.7		27.8		26.4	
315°	15.1		17.4		26.2	

	136.000 MHz	164.500 MHz	173.950 MHz
Av. Radiated Power:	15.64dBm	19.73dBm	21.21dBm

Performed by: David E. Lee, Lab Manager

Page Number 12 of 46.

Name of Test: Unwanted Emissions (Transmitter Conducted)

Specification: 47 CFR 2.1051

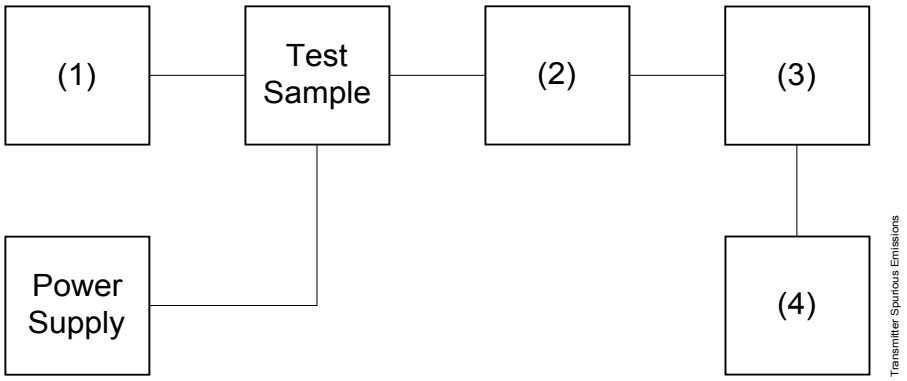
Guide: ANSI/TIA/EIA-603-1992, Paragraph 2.2.13

Measurement Procedure

A) The emissions were measured for the worst case as follows:
   1). within a band of frequencies defined by the carrier frequency plus and minus one channel.
   2). from the lowest frequency generated in the EUT and to at least the 10th harmonic of the carrier frequency, or 40 GHz, whichever is lower.

B) The magnitude of spurious emissions that are attenuated more than 20 dB below the permissible value need not be specified.

Transmitter Test Set-Up: Spurious Emission



	Asset	Description	s/n
(1) **Audio Oscillator/Generator**			
X	i00017	HP 8903A Audio Analyzer	2216A01753
	i00002	HP 3336B Synthesizer / Level Gen.	1931A01465
(2) **Coaxial Attenuator**			
X	i00231/2	PASTERNACK PE7021-30 (30 dB)	231 or 232
	i0012/3	NARDA 766 (10 dB)	7802 or 7802A
(3) **Filters; Notch, HP, LP, BP**			
X	i00126	Eagle TNF-1 Notch Filter	100-250
	i00125	Eagle TNF-1 Notch Filter	50-60
	i00124	Eagle TNF-1 Notch Filter	250-850
(4) **Spectrum Analyzer**			
X	i00048	HP 8566B Spectrum Analyzer	2511A01467
	i00029	HP 8563E Spectrum Analyzer	3213A00104

Name of Test: Unwanted Emissions (Transmitter Conducted)

Measurement Results
(Worst Case)

Summary:

Frequency of carrier, MHz		=	136.000, 155.000, 173.950
Spectrum Searched, GHz		=	0 to 10 x F_C
Maximum Response, Hz		=	3050
All Other Emissions		=	≥ 20 dB Below Limit
Limit(s), dBc	25khz channel		43+(10xlog(5))= 49.99dBc
	12.5kHz channel		50+(10xlog(5))= 56.99dBc

All emissions measured on 25khz channels were less than 70dBc (-33dBm) at all three test frequencies.

All emissions measured on 12.5khz channels were less than 77dBc (-40dBm) at all three test frequencies.

Performed by: David E. Lee, Lab Manager

Page Number 14 of 46.

Name of Test: Field Strength of Spurious Radiation

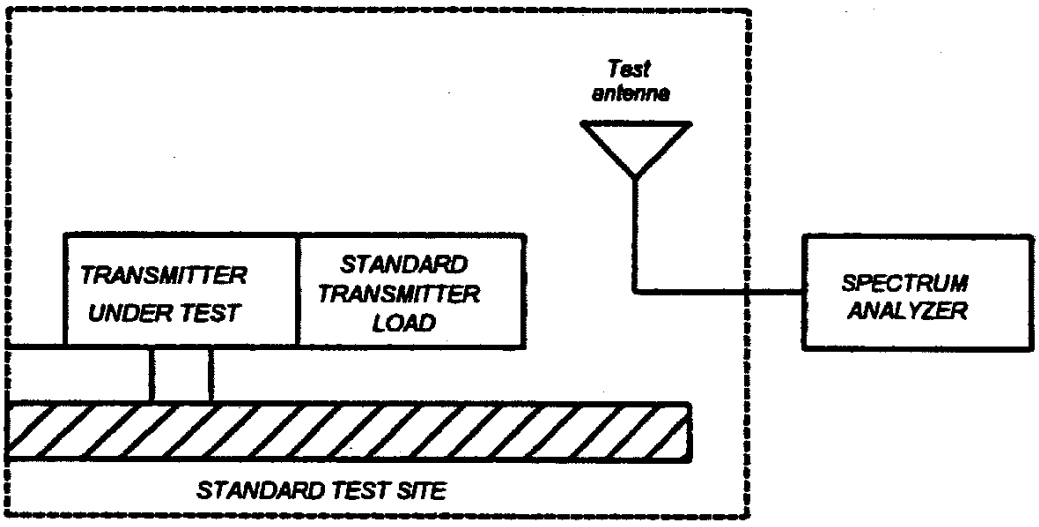
Specification: 47 CFR 2.1053(a)

Guide: ANSI/TIA/EIA-603-1992/2001, Paragraph 1.2.12 and Table 16, 47 CFR 22.917

Measurement Procedure

Definition:
Radiated spurious emissions are emissions from the equipment when transmitting into a non-radiating load on a frequency or frequencies which are outside an occupied band sufficient to ensure transmission of information of required quality for the class of communications desired.

Method of Measurement:
A) Connect the equipment as illustrated
B) Adjust the spectrum analyzer for the following settings:
   1) Resolution Bandwidth 100 kHz (<1 GHZ), 1 MHZ (> 1GHz).
   2) Video Bandwidth ≥ 3 times Resolution Bandwidth, or 30 kHz (22.917)
   3) Sweep Speed ≤2000 Hz/second
   4) Detector Mode = Mean or Average Power
C) Place the transmitter to be tested on the turntable in the standard test site. The transmitter is transmitting into a non-radiating load that is placed on the turntable. The RF cable to this load should be of minimum length.

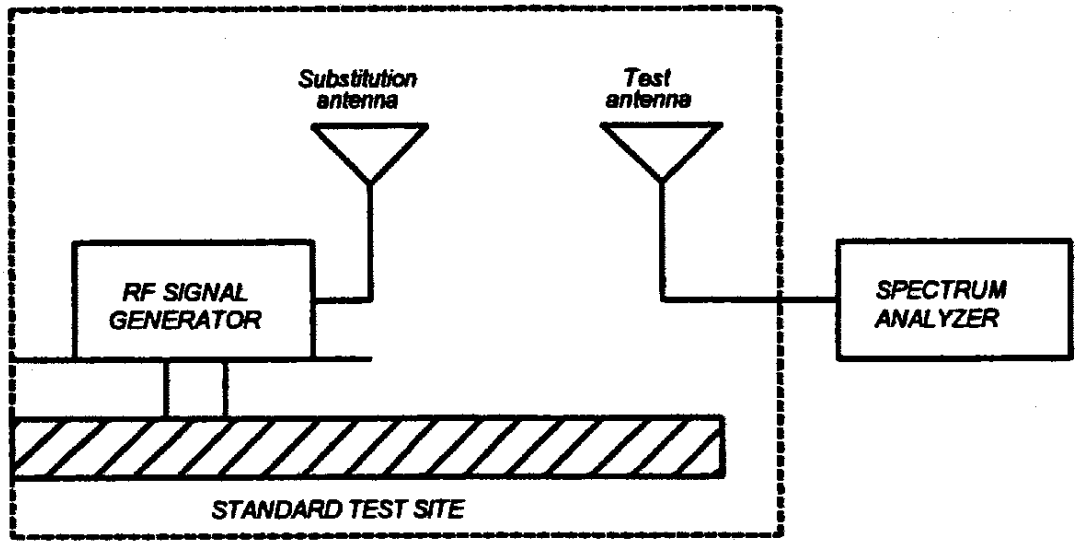


Name of Test: Field Strength of Spurious Radiation (Cont.)

D) For each spurious measurement the test antenna should be adjusted to the correct length for the frequency involved. This length may be determined from a calibration ruler supplied with the equipment. Measurements shall be made from the lowest radio frequency generated in the equipment to the tenth harmonic of the carrier, except for the region close to the carrier equal to ± the test bandwidth (see section 1.3.4.4).

E) For each spurious frequency, raise and lower the test antenna from 1 m to 4 m to obtain a maximum reading on the spectrum analyzer with the test antenna at horizontal polarity. Repeat this procedure to obtain the highest possible reading. Record this maximum reading.

F) Repeat step E) for each spurious frequency with the test antenna polarized vertically.



G) Reconnect the equipment as illustrated.

H) Keep the spectrum analyzer adjusted as in step B).

I) Remove the transmitter and replace it with a substitution antenna (the antenna should be half-wavelength for each frequency involved). The center of the substitution antenna should be approximately at the same location as the center of the transmitter. At lower frequencies, where the substitution antenna is very long, this will be impossible to achieve when the antenna is polarized vertically. In such case the lower end of the antenna should be 0.3 m above the ground.

Name of Test: Field Strength of Spurious Radiation (Cont.)

J) Feed the substitution antenna at the transmitter end with a signal generator connected to the antenna by means of a non-radiating cable. With the antennas at both ends horizontally polarized and with the signal generator tuned to a particular spurious frequency, raise and lower the test antenna to obtain a maximum reading at the spectrum analyzer. Adjust the level of the signal generator output until the previously recorded maximum reading for this set of conditions is obtained. This should be done carefully repeating the adjustment of the test antenna and generator output.

K) Repeat step J) with both antennas vertically polarized for each spurious frequency.

L) Calculate power in dBm into a reference ideal half-wave dipole antenna by reducing the readings obtained in steps J) and K) by the power loss in the cable between the generator and the antenna and further corrected for the gain of the substitution antenna used relative to an ideal half-wave dipole antenna.

M) The levels recorded in step L) are absolute levels of radiated spurious emissions in dBm. The radiated spurious emissions in dB can be calculated by the following:

Radiated spurious emissions dB =

$10\log_{10}$(TX power in watts/0.001) – the levels in step l)

NOTE: It is permissible that other antennas provided can be referenced to a dipole.

Test Equipment

	Asset	Description	s/n	Cycle	Last Cal
Transducer					
X	i00088	EMCO 3109-B 25MHz-300MHz	2336	12 mo.	Sep-03
X	i00089	Aprel 2001 200MHz-1GHz	001500	12 mo.	Sep-03
X	i00103	EMCO 3115 1GHz-18GHz	9208-3925	12 mo.	Jan-04
Amplifier					
	i00028	HP 8449A	2749A00121	12 mo.	May-04
Spectrum Analyzer					
	i00029	HP 8563E	3213A00104	12 mo.	May-04
X	i00033	HP 85462A	3625A00357	12 mo.	Aug-03
Substitution Generator					
X	i00067	HP 8920A Communication TS	3345U01242	12 mo.	Oct-03
	i00207	HP 8753D Network Analyzer	3410A08514	12 mo.	Jul-03

Microphone, Antenna Port, and Cabling

Microphone Yes Cable Length 1.0 Meters

Antenna Port Terminated Yes Load 50 ohms Antenna Gain N/A

All Ports Terminated by Load Yes Peripheral Yes

Name of Test: Field Strength of Spurious Radiation

Measurement Results

g0450025: 2004-May-10 Mon 10:28:00
STATE: 2:High Power Ambient Temperature: 23°C ± 3°C

Frequency Tuned, MHz	Frequency Emission, MHz	ERP, dBm	ERP, dBc
136.000	272.000250	-34.6	-71.6
164.500	329.002500	-47.5	-84.5
173.950	347.902500	-51.4	-88.4
136.000	408.000250	-51.2	-88.2
164.500	493.502500	-32.5	-69.5
173.950	521.852500	-39.6	-76.6
136.000	544.000250	-48.8	-85.8
164.500	658.002500	-48.8	-85.8
136.000	680.000250	-53.0	-90.0
173.950	695.802500	-41.6	-78.6
136.000	816.002500	-52.1	-89.1
164.500	822.502500	-52.7	-89.7
173.950	869.752500	-47.6	-84.6
136.000	952.002500	-47.0	-84.0
164.500	987.002500	-47.8	-84.8
173.950	1043.702500	-43.4	-80.4
136.000	1088.010000	-48.4	-85.4
164.500	1151.510000	-46.4	-83.4
173.950	1217.652500	-48.0	-85.0
136.000	1224.010000	-49.6	-86.6
164.500	1316.010000	-47.9	-84.9
136.000	1360.010000	-47.8	-84.8
173.950	1391.602500	-47.0	-84.0
164.500	1480.510000	-46.1	-83.1
173.950	1565.567000	-44.3	-81.3
164.500	1645.010000	-42.8	-79.8
173.950	1739.517000	-41.1	-78.1

Performed by: David E. Lee, Lab Manager

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Name of Test: Emission Masks (Occupied Bandwidth)

Specification: 47 CFR 2.1049(c)(1)

Guide: ANSI/TIA/EIA-603-1992, Paragraph 2.2.11

Measurement Procedure

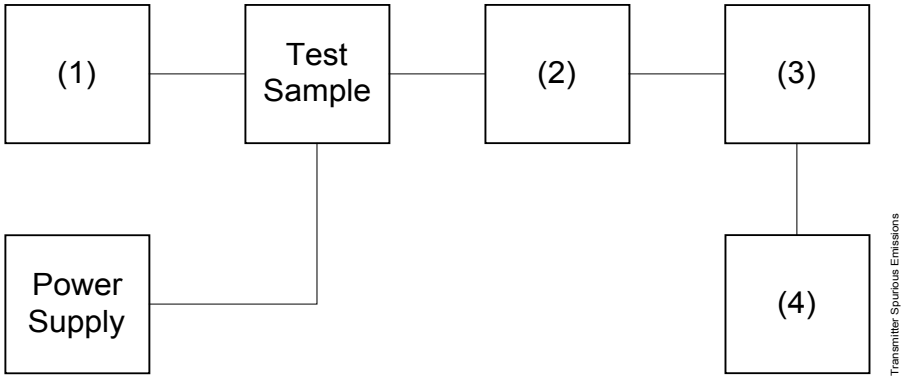
A) The EUT and test equipment were set up as shown below

B) For EUTs supporting audio modulation, the audio signal generator was adjusted to the frequency of maximum response and with output level set for ±2.5/±1.25 kHz deviation (or 50% modulation). With level constant, the signal level was increased 16 dB.

C) For EUTs supporting digital modulation, the digital modulation mode was operated to its maximum extent.

D) The Occupied Bandwidth was measured with the Spectrum Analyzer controls set as shown on the test results.

Transmitter Test Set-Up: Occupied Bandwidth



	Asset	Description	s/n
(1) **Audio Oscillator/Generator**			
X	i00017	HP 8903A Modulation Meter	2216A01753
(2) **Coaxial Attenuator**			
X	i00231/2	PASTERNACK PE7021-30 (30 dB)	231 or 232
	i00123	NARDA 766 (10 dB)	7802A
(3) **Interface**			
X	i00021	HP 8954A Transceiver Interface	2146A00159
(4) **Spectrum Analyzer**			
X	i00048	HP 8566B Spectrum Analyzer	2511A01467
	i00029	HP 8563E Spectrum Analyzer	3213A00104

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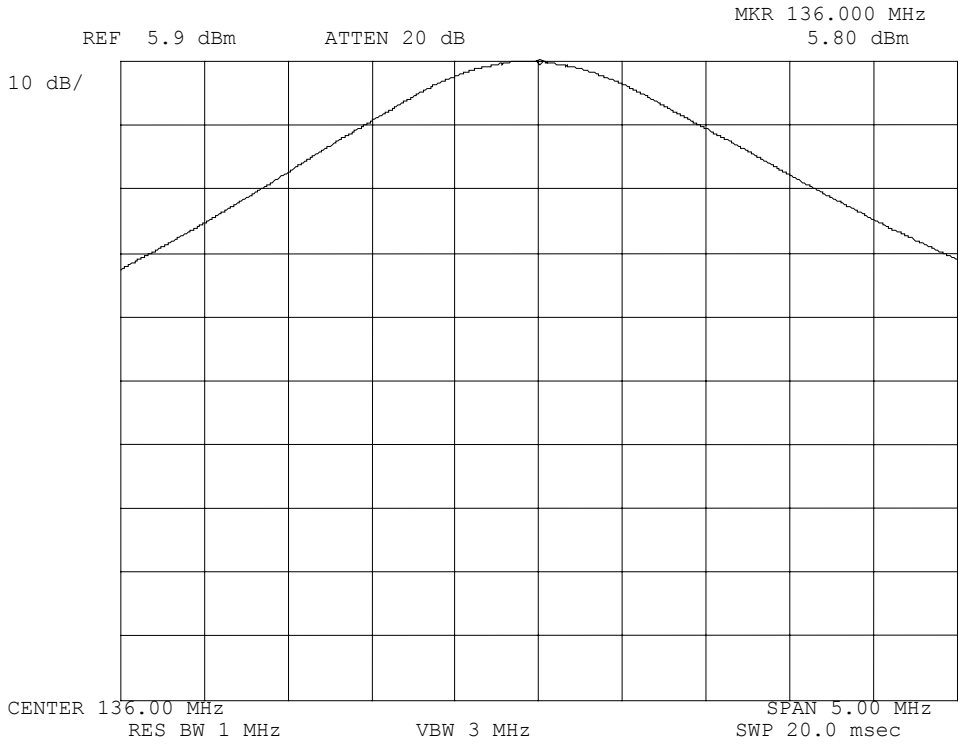
Name of Test: Emission Masks (Occupied Bandwidth)

Measurement Results

g0450018: 2004-May-07 Fri 03:10:00
State: 2:High Power Ambient Temperature: 23°C ± 3°C



Power: HIGH
Modulation: NONE
REFERENCE POWER – LOW CHANNEL

Performed by: David E. Lee, Lab Manager

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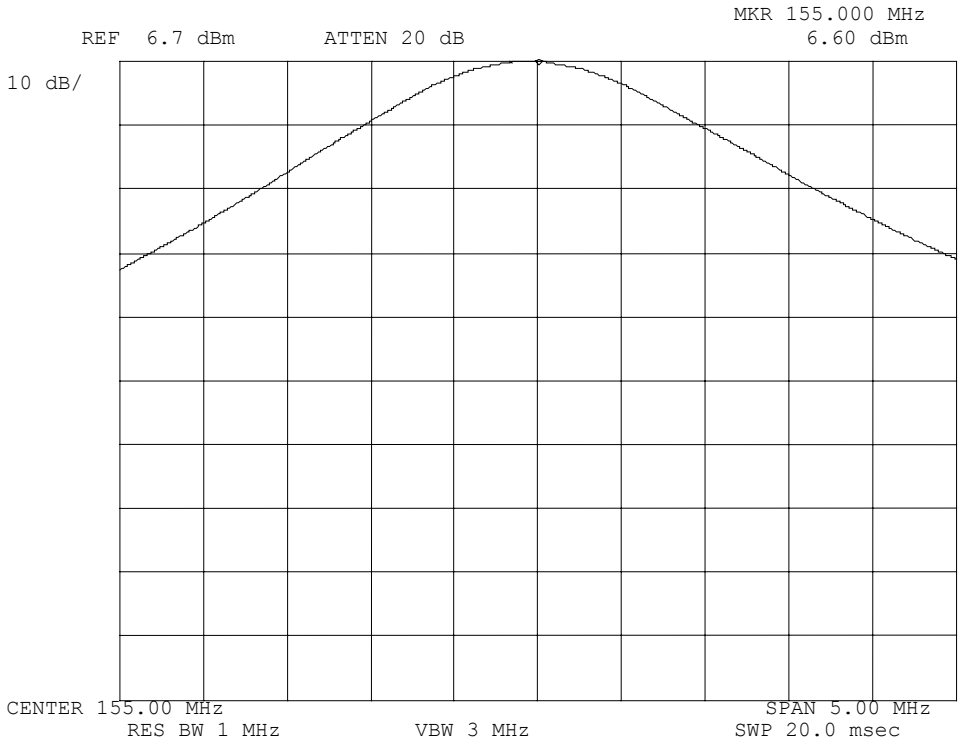
Name of Test: Emission Masks (Occupied Bandwidth)

Measurement Results

g0450019: 2004-May-07 Fri 03:11:00
State: 2:High Power Ambient Temperature: 23°C ± 3°C



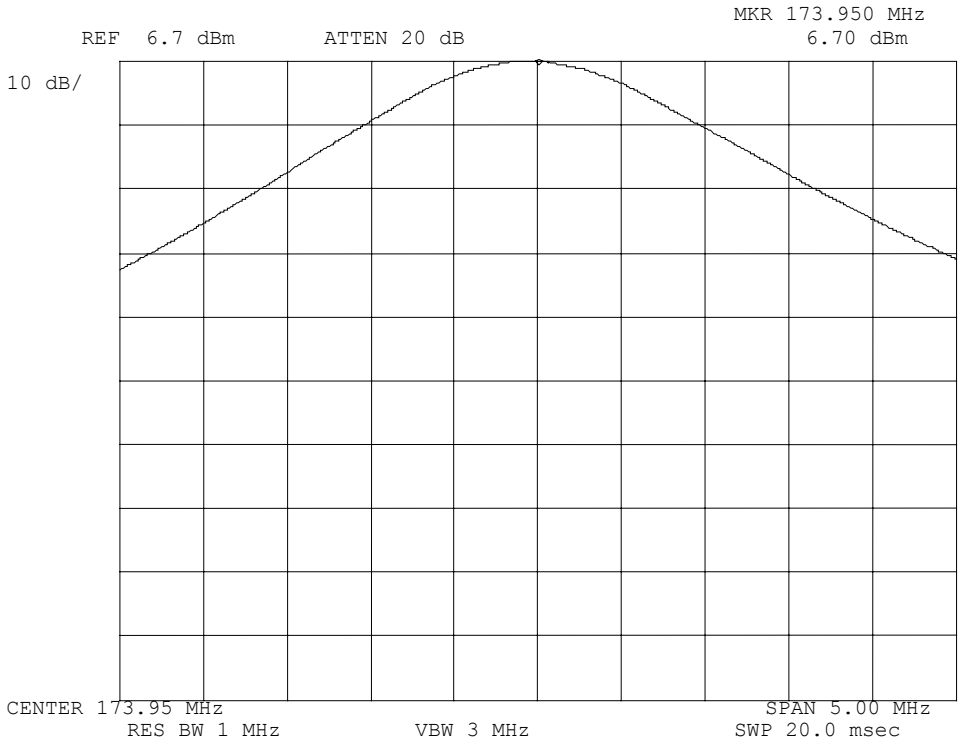
Power: HIGH
Modulation: NONE
REFERENCE POWER – MID CHANNEL

Performed by: David E. Lee, Lab Manager

Name of Test: Emission Masks (Occupied Bandwidth)

Measurement Results

g0450020: 2004-May-07 Fri 03:11:00
State: 2:High Power Ambient Temperature: 23°C ± 3°C



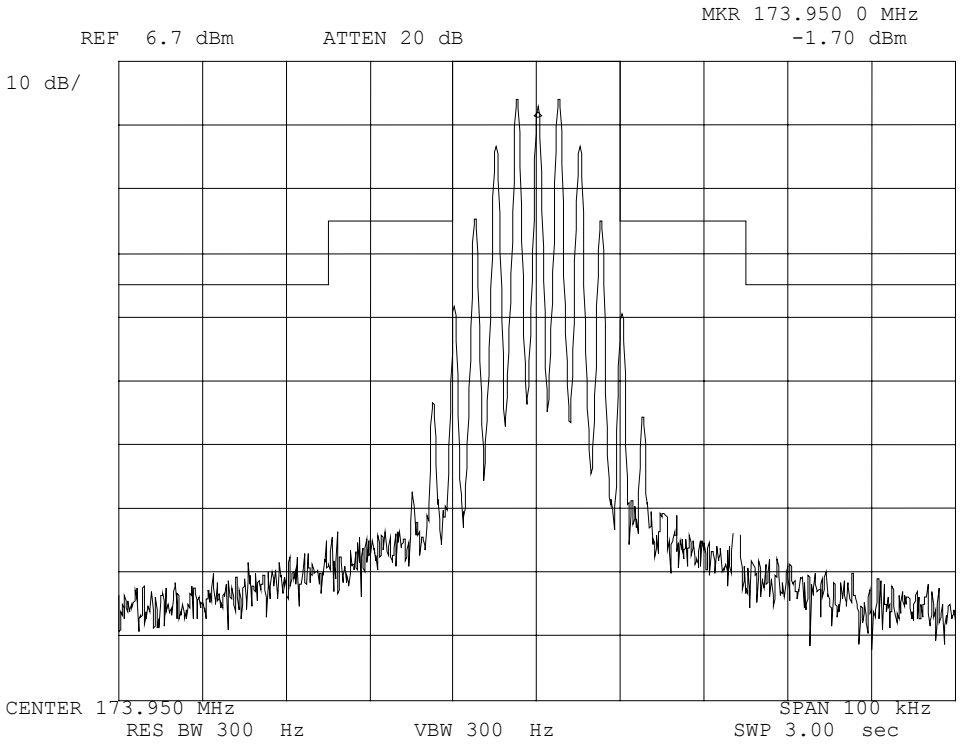
Power: HIGH
Modulation: NONE
REFERENCE POWER – HIGH CHANNEL

Performed by: David E. Lee, Lab Manager

Name of Test: Emission Masks (Occupied Bandwidth)

Measurement Results

g0450026: 2004-May-11 Tue 02:30:00
State: 2:High Power Ambient Temperature: 23°C ± 3°C



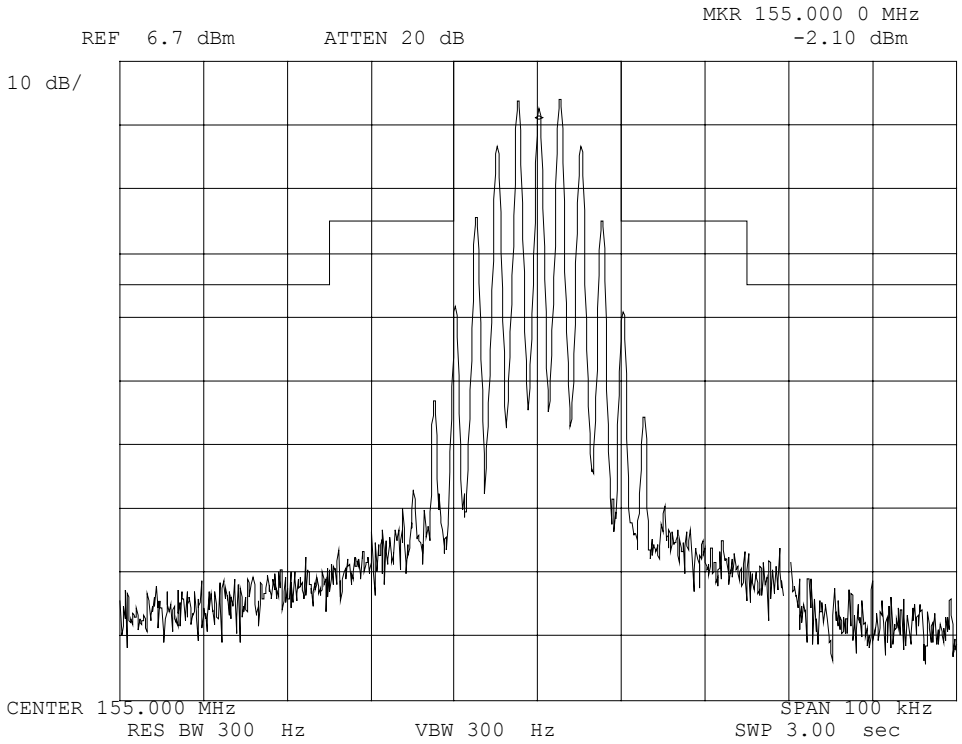
Power: HIGH
Modulation: VOICE: 2500 Hz SINE WAVE
MASK: B, VHF/UHF 25kHz, w/LPF

Performed by: David E. Lee, Lab Manager

Name of Test: Emission Masks (Occupied Bandwidth)

Measurement Results

g0450027: 2004-May-11 Tue 02:32:00
State: 2:High Power Ambient Temperature: 23°C ± 3°C



Power: HIGH
Modulation: VOICE: 2500 Hz SINE WAVE
MASK: B, VHF/UHF 25kHz, w/LPF

Performed by: David E. Lee, Lab Manager

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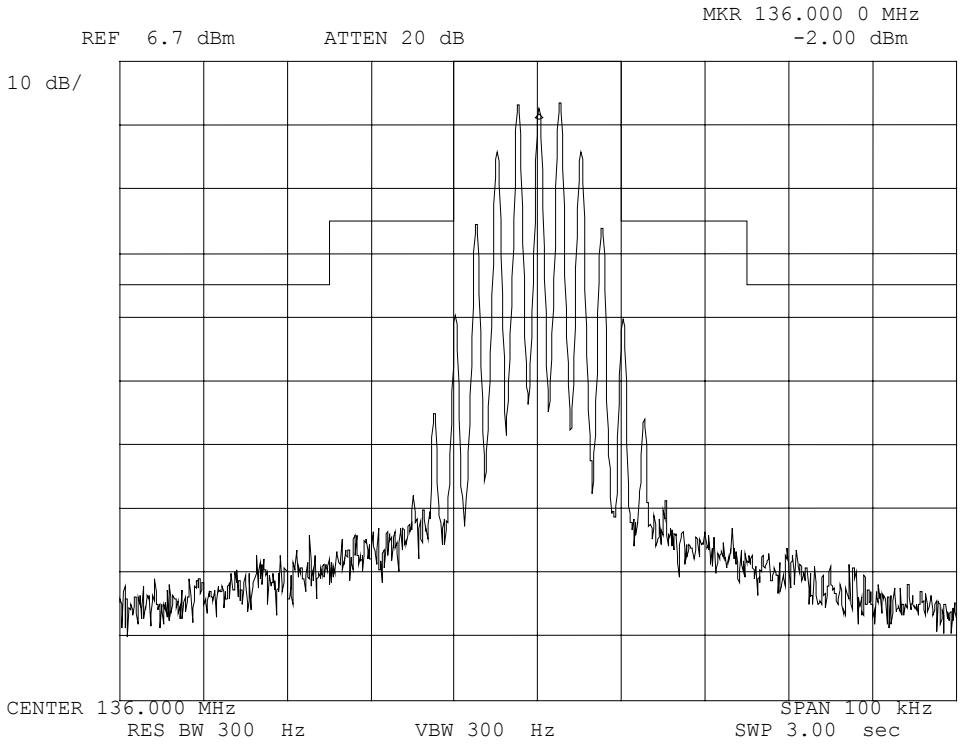
Name of Test: Emission Masks (Occupied Bandwidth)

Measurement Results

g0450028: 2004-May-11 Tue 02:33:00
State: 2:High Power Ambient Temperature: 23°C ± 3°C



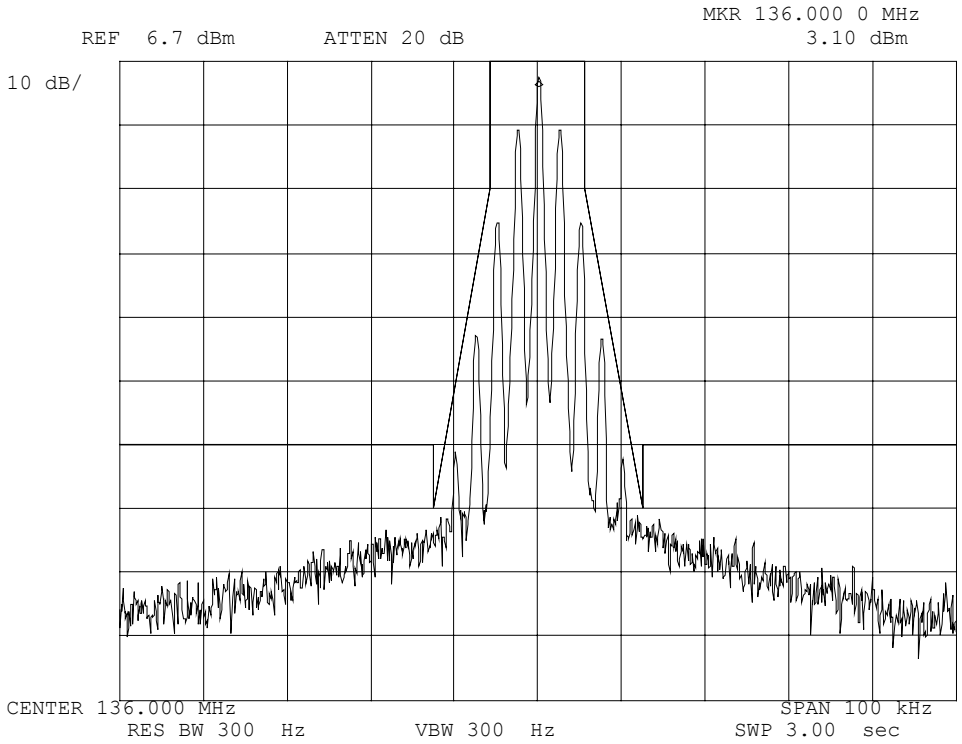
Power: HIGH
Modulation: VOICE: 2500 Hz SINE WAVE
MASK: B, VHF/UHF 25kHz, w/LPF

Performed by: David E. Lee, Lab Manager

Name of Test: Emission Masks (Occupied Bandwidth)

Measurement Results

g0450029: 2004-May-11 Tue 02:34:00
State: 2:High Power Ambient Temperature: 23°C ± 3°C



Power: HIGH
Modulation: VOICE: 2500 Hz SINE WAVE
MASK: D, VHF/UHF 12.5kHz BW

Performed by: David E. Lee, Lab Manager

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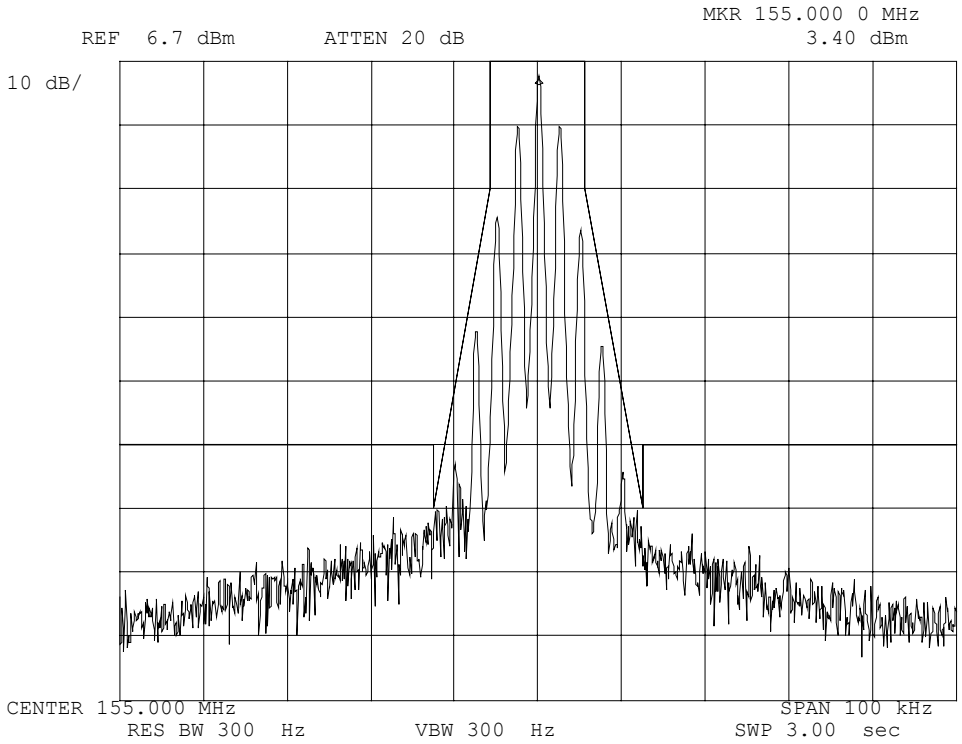
Name of Test: Emission Masks (Occupied Bandwidth)

Measurement Results

g0450030: 2004-May-11 Tue 02:35:00
State: 2:High Power Ambient Temperature: 23°C ± 3°C



Power: HIGH
Modulation: VOICE: 2500 Hz SINE WAVE
MASK: D, VHF/UHF 12.5kHz BW

Performed by: David E. Lee, Lab Manager

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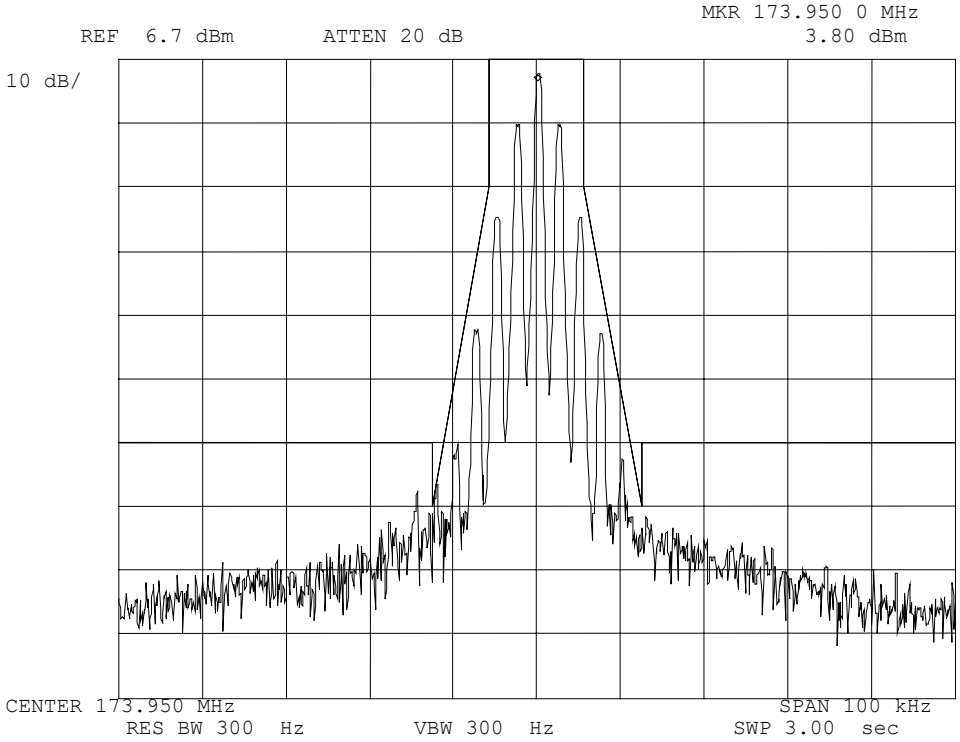
Name of Test: Emission Masks (Occupied Bandwidth)

Measurement Results

g0450031: 2004-May-11 Tue 02:36:00
State: 2:High Power Ambient Temperature: 23°C ± 3°C



Power: HIGH
Modulation: VOICE: 2500 Hz SINE WAVE
MASK: D, VHF/UHF 12.5kHz BW

Performed by: David E. Lee, Lab Manager

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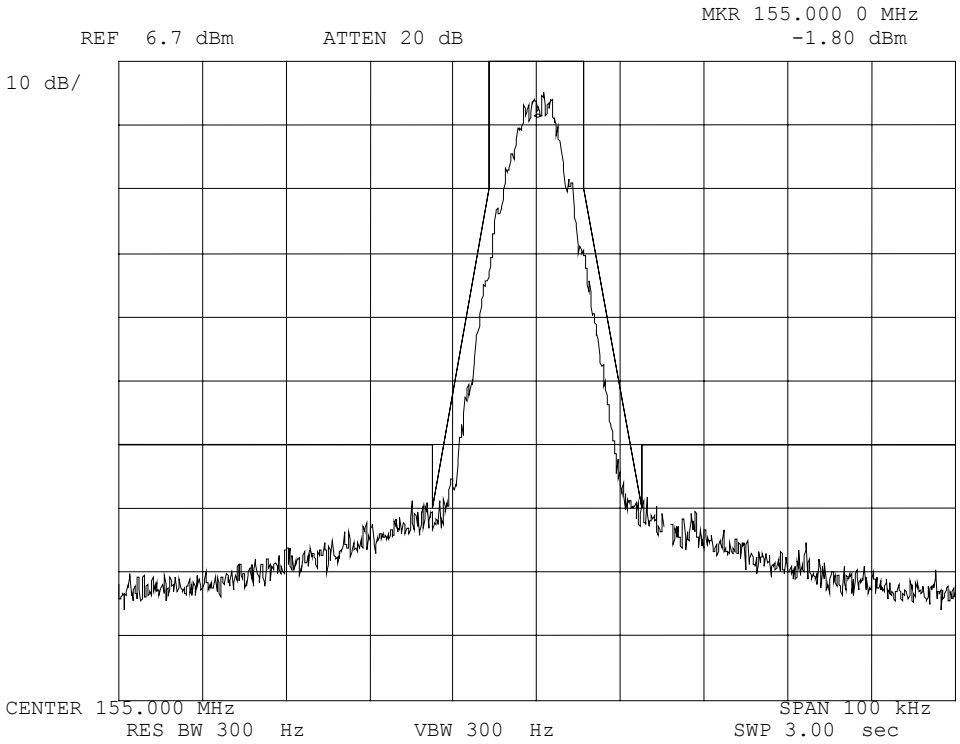
Name of Test: Emission Masks (Occupied Bandwidth)

Measurement Results

g0450032: 2004-May-11 Tue 02:45:00
State: 2:High Power Ambient Temperature: 23°C ± 3°C



Power: HIGH
Modulation: VOICE: 2500 Hz SINE WAVE
APCO25 VHF/UHF 12.5KHZ BW
(8K10F1E/F1D)

Performed by: David E. Lee, Lab Manager

Name of Test: Transient Frequency Behavior
Specification: 47 CFR 90.214
Guide: ANSI/TIA/EIA-603-1992, Paragraph 2.2.19

Test Equipment: As per attached page

Measurement Procedure

A) The EUT was setup as shown on the attached page, following TIA/EIA-603 steps a, b, and c as a *guide*.

B) The transmitter was turned on.

C) Sufficient attenuation was provided so that the transmitter carrier level measured at the output of the combiner was 40 dB below the maximum input level of the test receiver. This level was recorded.

D) The transmitter was turned off.

E) An RF signal generator (1) modulated with a 1 kHz tone at either 25, 12.5, or 6.25 kHz deviation, and set to the same frequency as the assigned transmitter frequency, (2) was adjusted to a level -20 dB below the level recorded for step C) above, measured at the output of the combiner. This level was then fixed for the remainder of the test.

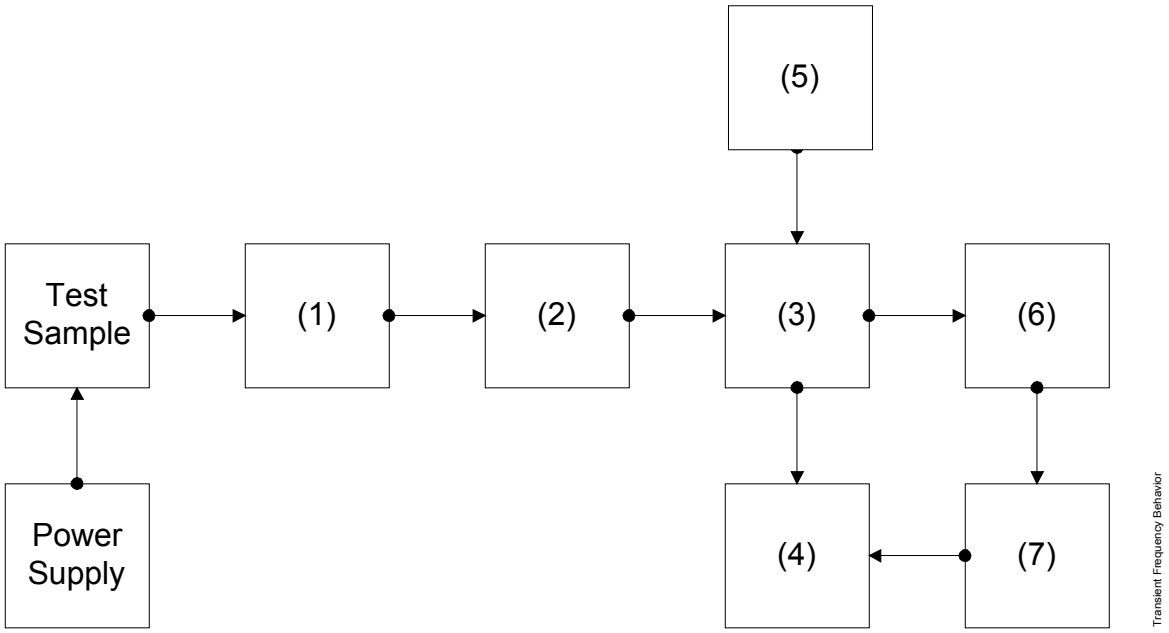
F) The oscilloscope was setup using TIA/EIA-603 steps j and k as a guide, and to either 10 ms/div (UHF) or 5 ms/div (VHF).

G) The 30 dB attenuator was removed, the transmitter was turned on, and the level of the carrier at the output of the combiner was recorded.

H) The carrier on-time as referenced in TIA/EIA-603 steps m, n, and o was captured and plotted. The carrier off-time as referenced in TIA/EIA-603 steps p, q, r, and s was captured and plotted.

Performed by: David E. Lee, Lab Manager

Transient Frequency Behavior



	Asset	Description	s/n
(1) **Attenuator** (Removed after 1st step)			
X	i00231/2	PASTERNACK PE7021-30 (30 dB)	231 or 232
(2) **Attenuator**			
X	i00231/2	PASTERNACK PE7021-30 (30 dB)	231 or 232
	i00122/3	NARDA 766 (10 dB)	7802 or 7802A
(3) **Combiner**			
X	i00154	4 x 25 Ω Combiner	154
(4) **Crystal Decoder**			
X	i00159	HP 8470B Crystal Detector	1822A10054
(5) **RF Signal Generator**			
X	i00067	HP 8920A Communication TS	3345U01242
(6) **Modulation Analyzer**			
X	i00020	HP 8901A Modulation Meter	2105A01087
(7) **Oscilloscope**			
X	i00030	HP 54502A Digital Oscilloscope	2927A00209

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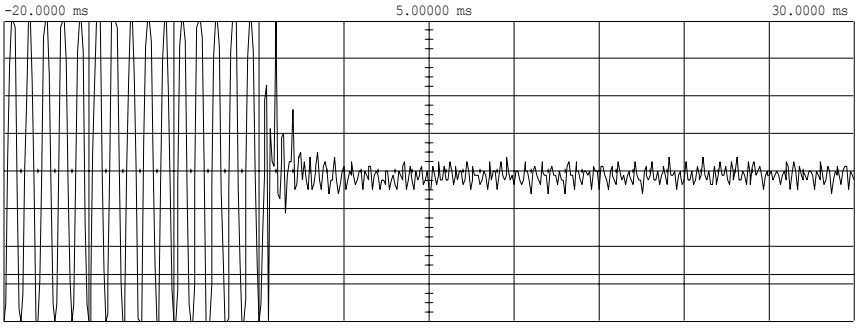
Name of Test: Transient Frequency Behavior

2004-May-10, 03:49, Mon Ambient Temperature: 23°C ± 3°C



	Timebase	Delay/Pos	Reference	Mode
Main	5.00 ms/div	-20.0000 ms	Left	Repetitive
	Sensitivity	**Offset**	**Probe**	**Coupling**
Channel 1	50.0 mV/div	5.000 mV	1.000 :1	ac (1M ohm)

Trigger mode : Edge
On Negative Edge Of Chan2
Trigger Level
Chan2 = -27.500 mV (noise reject ON)
Holdoff = 40.000 ns

Power: High
Modulation: 25 kHz Deviation
Description: Carrier On

Performed by: David E. Lee, Lab Manager

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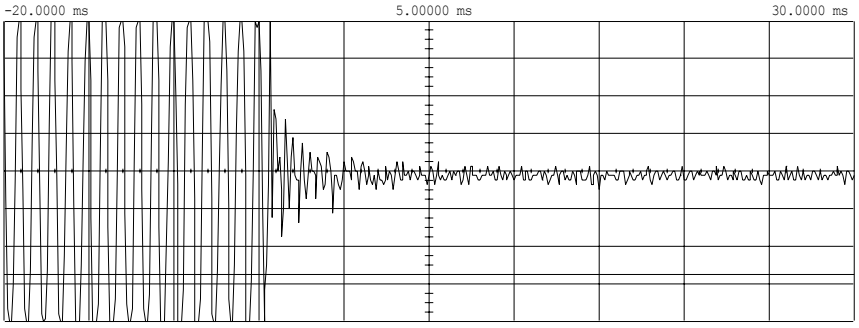
Name of Test: Transient Frequency Behavior

2004-May-10, 03:51, Mon Ambient Temperature: 23°C ± 3°C



	Timebase	Delay/Pos	Reference	Mode
Main	5.00 ms/div	-20.0000 ms	Left	Repetitive
	Sensitivity	**Offset**	**Probe**	**Coupling**
Channel 1	50.0 mV/div	5.000 mV	1.000 :1	ac (1M ohm)

Trigger mode : Edge
On Negative Edge Of Chan2
Trigger Level
Chan2 = -27.500 mV (noise reject ON)
Holdoff = 40.000 ns

Power: High
Modulation: 12.5 kHz Deviation
Description: Carrier On

Performed by: David E. Lee, Lab Manager

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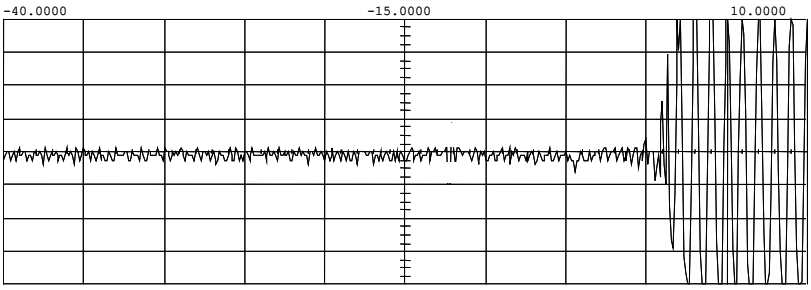
Name of Test: Transient Frequency Behavior

2004-May-10, 03:56, Mon Ambient Temperature: 23°C ± 3°C



	Timebase	Delay/Pos	Reference
Main	5.00 ms/div	-40.0000 ms	Left

	Sensitivity	Offset	Probe
Channel 1	50.0 mV/div	5.000 mV	1.000 :1 ac

Trigger mode :
On Positive Edge Of
Trigger
Chan2 = -22.500 mV (noise reject
Holdoff = 40.000

Power: High
Modulation: 12.5 kHz Deviation
Description: Carrier Off

Performed by: David E. Lee, Lab Manager

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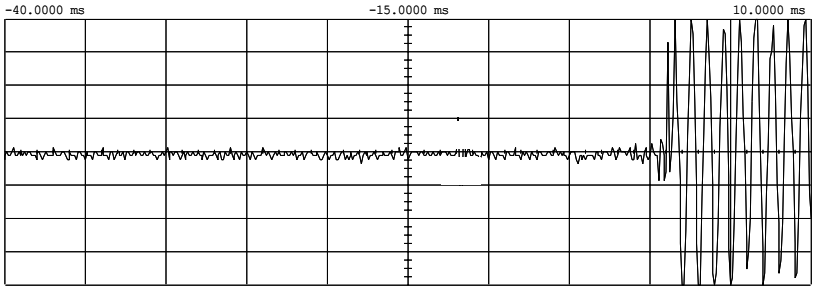
Name of Test: Transient Frequency Behavior

2004-May-10, 03:58, Mon Ambient Temperature: 23°C ± 3°C



	Timebase	Delay/Pos	Reference	Mode
Main	5.00 ms/div	-40.0000 ms	Left	Repetitive
	Sensitivity	**Offset**	**Probe**	**Coupling**
Channel 1	70.0 mV/div	5.000 mV	1.000 :1	ac (1M ohm)

Trigger mode : Edge
On Positive Edge Of Chan2
Trigger Level
Chan2 = -22.500 mV (noise reject ON)
Holdoff = 40.000 ns

Power: High
Modulation: 25 kHz Deviation
Description: Carrier Off

Performed by: David E. Lee, Lab Manager

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Name of Test: Audio Low Pass Filter (Voice Input)

Specification: 47 CFR 2.1047(a)

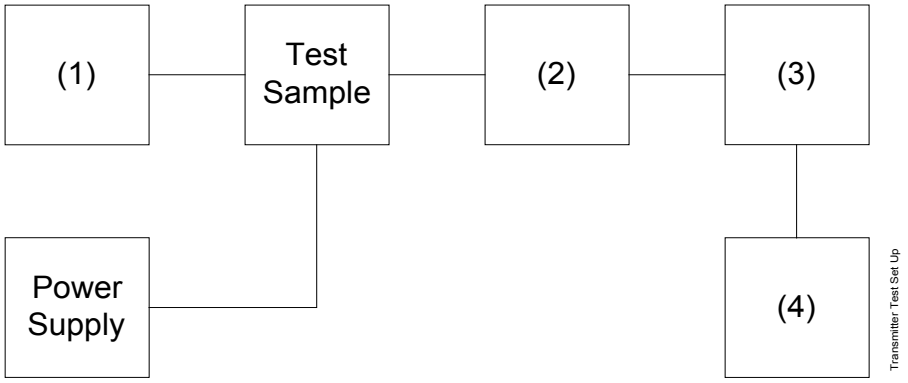
Guide: ANSI/TIA/EIA-603-1992, Paragraph 2.2.15

Measurement Procedure

A) The EUT and test equipment were set up such that the audio input was connected at the input to the modulation limiter, and the modulated stage.

B) The audio output was connected at the output to the modulated stage.

Transmitter Test Set-Up: Response of Low Pass Filter

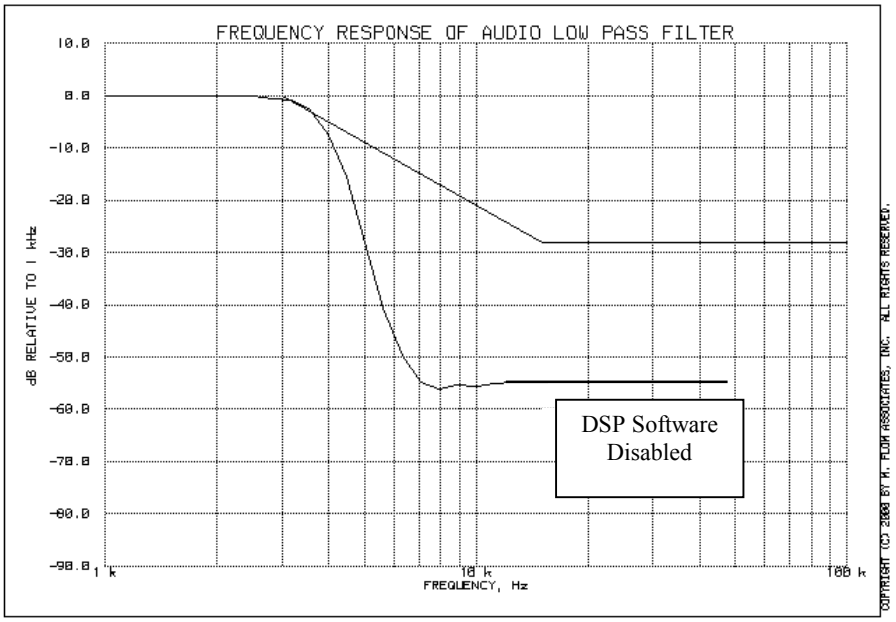


	Asset	Description	s/n
(1) **Audio Oscillator**			
X	i00002	HP 3336B Synthesizer / Level Gen.	1931A01465
(2) **Coaxial Attenuator**			
	i00122/3	NARDA 766 (10dB)10	7802 or 7802A
X	i00231/2	PASTERNACK PE7021-30 (30 dB)	231 or 232
(3) **Modulation Analyzer**			
X	i00020	HP 8901A Modulation Meter	2105A01087
(4) **Audio Analyzer**			
X	i00001	HP 3586B Selective Level Meter	1928A01360

Name of Test: Audio Low Pass Filter (Voice Input)

Measurement Result

g0450005: 2004-May-11 Tue 03:14:00
State: 0:General Ambient Temperature: 23°C ± 3°C



The EUT audio characteristics are controlled by a DSP to reduce the dynamic noise and interference in the transmitted signal. To demonstrate the static parameters of the system the DSP software has to be disabled. These plots represent the worst-case conditions of the EUT, which will not be present in the operational unit.

Performed by: David E. Lee, Lab Manager

Page Number 37 of 46.

Name of Test: Audio Frequency Response

Specification: 47 CFR 2.1047(a)

Guide: ANSI/TIA/EIA-603-1992, Paragraph 2.2.6

Measurement Procedure

A) The EUT and test equipment were set up as shown below.

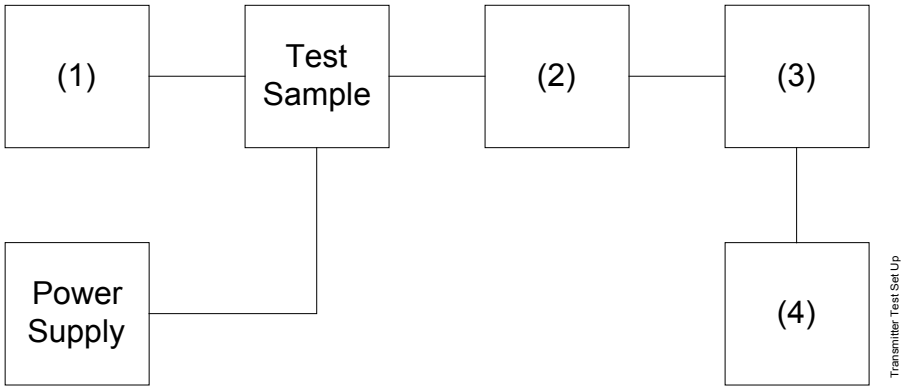
B) The audio signal generator was connected to the audio input circuit/microphone of the EUT.

C) The audio signal input was adjusted to obtain 20% modulation at 1 kHz, and this point was taken as the 0 dB reference level.

D) With input levels held constant and below limiting at all frequencies, the audio signal generator was varied from 100 Hz to 50 kHz.

E) The response in dB relative to 1 kHz was measured, using the HP 8901A Modulation Meter.

Transmitter Test Set-Up: Audio Frequency Response



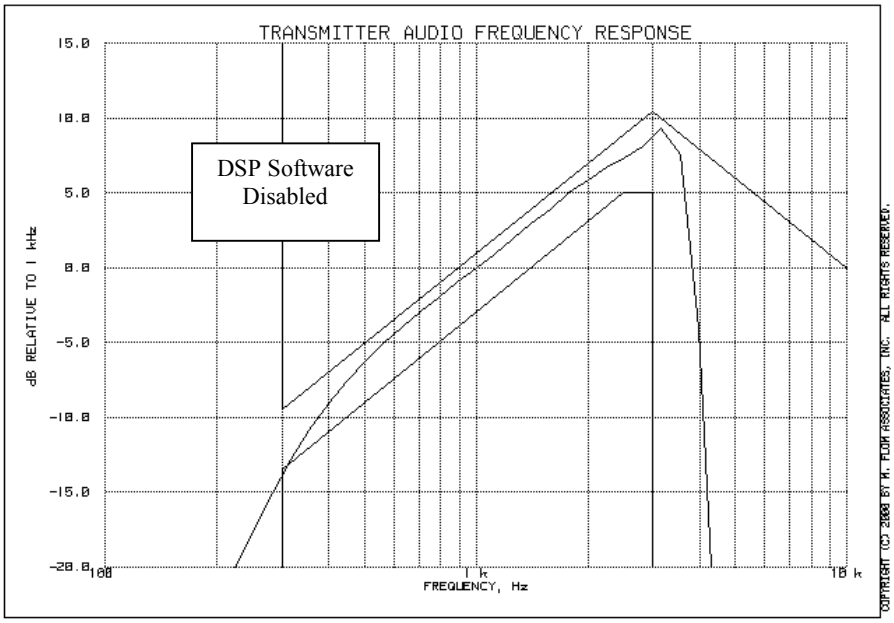
	Asset	Description	s/n
(1) **Audio Oscillator**			
X	i00017	HP 8903A Audio Analyzer	2216A01753
(2) **Coaxial Attenuator**			
	i00122/3	NARDA 766-(10 dB)	7802 or 7802A
X	i00231/2	PASTERNACK PE7021-30 (30 dB)	231 or 232
(3) **Modulation Analyzer**			
X	i00020	HP 8901A Modulation Meter	2105A01087
(4) **Audio Analyzer**			
X	i00017	HP 8903A Audio Analyzer	2216A01753

Page Number 38 of 46.

Name of Test: Audio Frequency Response

Measurement Results

g0450003: 2004-May-11 Tue 02:51:00
State: 0:General Ambient Temperature: 23°C ± 3°C



Frequency of Maximum Audio Response, Hz = 3050

The EUT audio characteristics are controlled by a DSP to reduce the dynamic noise and interference in the transmitted signal. To demonstrate the static parameters of the system the DSP software has to be disabled. These plots represent the worst-case conditions of the EUT, which will not be present in the operational unit.

Performed by: David E. Lee, Lab Manager

Page Number 39 of 46.

Name of Test: Modulation Limiting

Specification: 47 CFR 2.1047(b)

Guide: ANSI/TIA/EIA-603-1992, Paragraph 2.2.3

Measurement Procedure

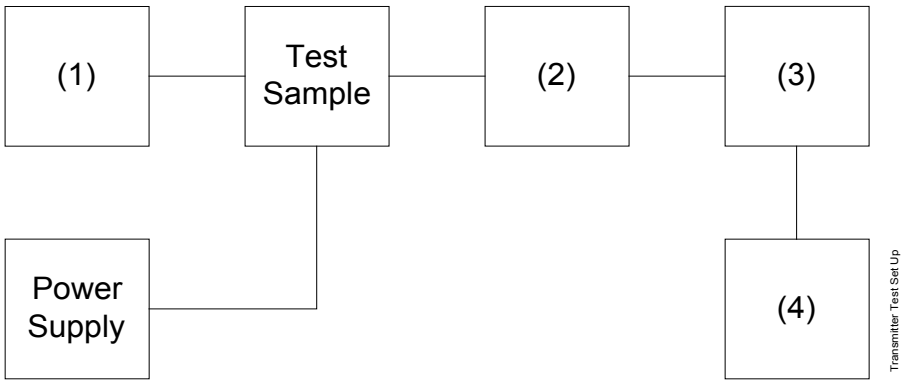
A) The signal generator was connected to the input of the EUT as shown below.

B) The modulation response was measured for each of three frequencies (one of which was the frequency of maximum response), and the input voltage was varied and was observed on an HP 8901A Modulation Analyzer.

C) The input level was varied from 30% modulation (±1.5 kHz deviation) to at least 20 dB higher than the saturation point.

D) Measurements were performed for both negative and positive modulation and the respective results were recorded.

Transmitter Test Set-Up: Modulation Limiting



	Asset	Description	s/n
(1) **Audio Oscillator**			
X	i00017	HP 8903A Audio Analyzer	2216A01753
(2) **Coaxial Attenuator**			
	i0012/23	NARDA 766-(10 dB)	7802 or 7802A
X	i00231/2	PASTERNACK PE7021-30 (30 dB)	231 or 232
(3) **Modulation Analyzer**			
X	i00020	HP 8901A Modulation Meter	2105A01087
(4) **Audio Analyzer**			
X	i00017	HP 8903A Audio Analyzer	2216A01753

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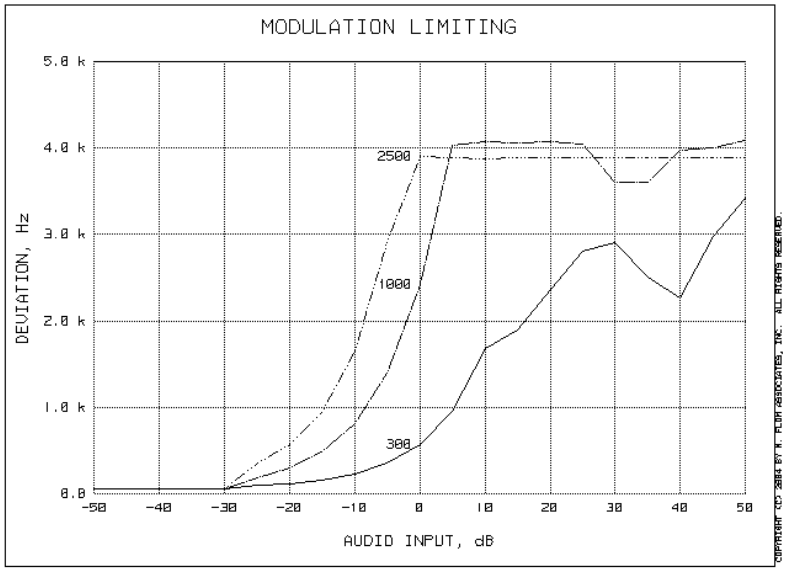
Name of Test: Modulation Limiting

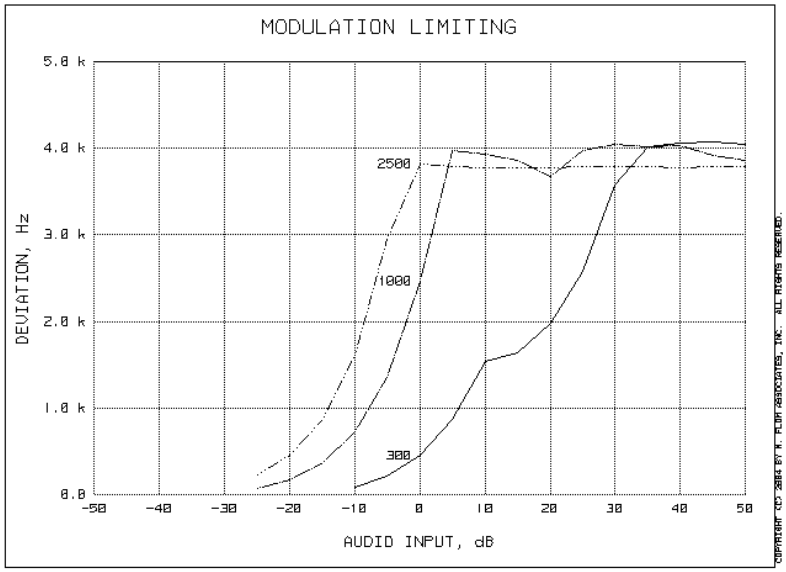
Measurement Results

g0450006: 2004-May-11 Tue 03:16:00
State: 0:General Ambient Temperature: 23°C ± 3°C

Positive Peaks:



Negative Peaks:



Performed by: David E. Lee, Lab Manager

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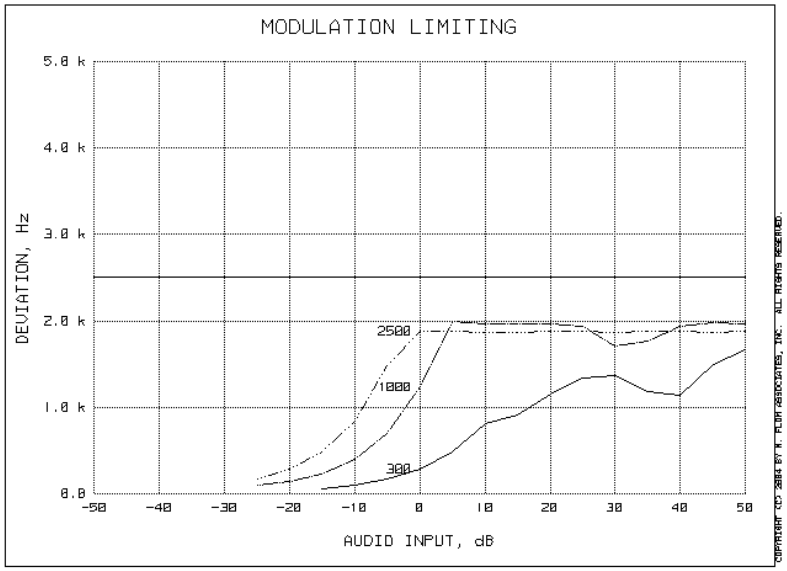
Name of Test: Modulation Limiting

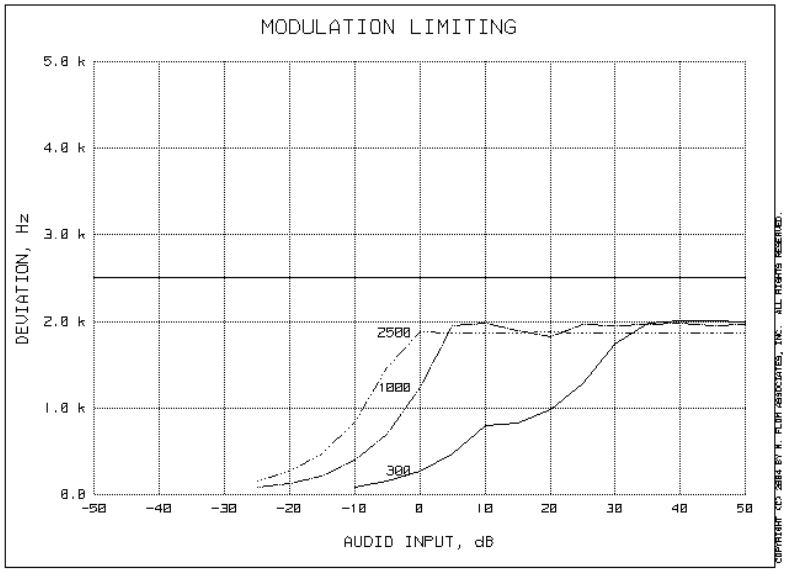
Measurement Results

g0450007: 2004-May-11 Tue 03:21:00
State: 0:General Ambient Temperature: 23°C ± 3°C

Positive Peaks:



Negative Peaks:



Performed by: David E. Lee, Lab Manager

Page Number 42 of 46.

Name of Test: Frequency Stability (Temperature Variation)

Specification: 47 CFR 2.1055(a)(1)

Guide: ANSI/TIA/EIA-603-1992, Paragraph 2.2.2

Measurement Procedure

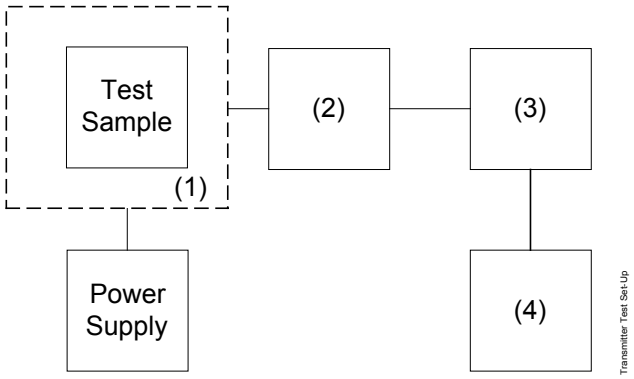
A) The EUT and test equipment were set up as shown on the following page.

B) With all power removed, the temperature was decreased to -30°C and permitted to stabilize for three hours. Power was applied and the maximum change in frequency was noted within one minute.

C) With power OFF, the temperature was raised in 10°C steps. The sample was permitted to stabilize at each step for at least one-half hour. Power was applied and the maximum frequency change was noted within one minute.

D) The temperature tests were performed for the worst case.

Transmitter Test Set-Up: Temperature Variation



	Asset	Description	s/n
(1) **Temperature, Humidity, Vibration**			
X	i00027	Tenney Temp. Chamber	9083-765-234
(2) **Coaxial Attenuator**			
X	i00231/2	PASTERNACK PE7021-30 (30 dB)	231 or 232
	i00122/3	NARDA 766 (10 dB)	7802 or 7802A
(3) **RF Power**			
X	i00067	HP 8920A Communications TS	3345U01242
(4) **Frequency Counter**			
X	i00067	HP 8920A Communications TS	3345U01242

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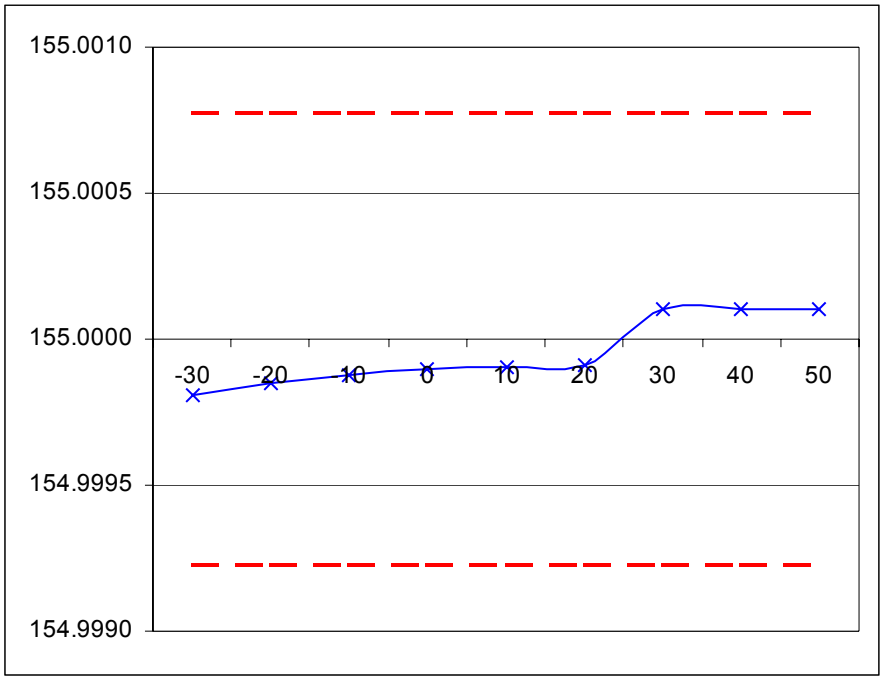
Name of Test: Frequency Stability (Temperature Variation)

Measurement Results

State: Room Temperature: 23°C ± 3°C



Performed by: David E. Lee, Lab Manager

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Name of Test: Frequency Stability (Voltage Variation)

Specification: 47 CFR 2.1055(d)(1)

Guide: ANSI/TIA/EIA-603-1992, Paragraph 2.2.2

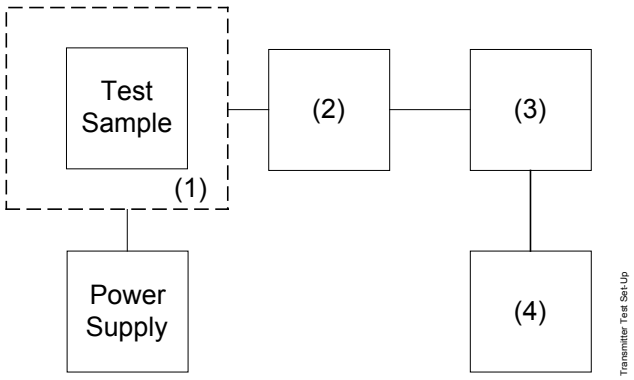
Measurement Procedure

A) The EUT was placed in a temperature chamber (if required) at 25±5°C and connected as shown below.

B) The power supply voltage to the EUT was varied from 85% to 115% of the nominal value measured at the input to the EUT.

C) The variation in frequency was measured for the worst case.

Transmitter Test Set-Up: Voltage Variation



	Asset	Description	s/n
(1) **Temperature, Humidity, Vibration**			
	i00027	Tenney Temp. Chamber	9083-765-234
(2) **Coaxial Attenuator**			
X	i00231/2	PASTERNACK PE7021-30 (30 dB)	231 or 232
	i00122/3	NARDA 766 (10 dB)	7802 or 7802A
(3) **RF Power**			
X	i00020	HP 8901A Power Mode	2105A01087
(4) **Frequency Counter**			
X	i00020	HP 8901A Frequency Mode	2105A01087

Results: Frequency Stability (Voltage Variation)

State: Ambient Temperature: 23°C ± 3°C

Limit, ppm	=	2.5
Limit, Hz	=	387.5
Battery End Point (Voltage)	=	6.3

% of STV	Voltage	Frequency, MHz	Change, Hz	Change, ppm
115	8.6	154.999850	-150	-1.0
100	7.5	154.999850	-150	-1.0
85	6.4	154.999850	-150	-1.0
80	6.0	154.999850	-150	-1.0

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Name of Test: Necessary Bandwidth and Emission Bandwidth

Specification: 47 CFR 2.202(g)

Modulation = 16K0F3E

Necessary Bandwidth Calculation:

Maximum Modulation (M), kHz	=	3
Maximum Deviation (D), kHz	=	5
Constant Factor (K)	=	1
Necessary Bandwidth (B_N), kHz	=	(2xM)+(2xDxK)
	=	16.0

Modulation = 11K0F3E

Necessary Bandwidth Calculation:

Maximum Modulation (M), kHz	=	3
Maximum Deviation (D), kHz	=	2.5
Constant Factor (K)	=	1
Necessary Bandwidth (B_N), kHz	=	(2xM)+(2xDxK)
	=	11.0

Modulation = 8K10F1E

Necessary Bandwidth Calculation:

Maximum Modulation (M), kHz	=	1.5
Maximum Deviation (D), kHz	=	2.5
Constant Factor (K)	=	1
Necessary Bandwidth (B_N), kHz	=	(2xM)+(2xDxK)
	=	8.0

Modulation = 8K10F1D

Necessary Bandwidth Calculation:

Maximum Modulation (M), kHz	=	3
Maximum Deviation (D), kHz	=	1.25
Constant Factor (K)	=	1
Necessary Bandwidth (B_N), kHz	=	(2xM)+(2xDxK)
	=	8.0

Performed by: David E. Lee, Lab Manager

END OF TEST REPORT

Testimonial
and
Statement of Certification

This is to Certify:

1. **That** the application was prepared either by, or under the direct supervision of, the undersigned.

2. **That** the technical data supplied with the application was taken under my direction and supervision.

3. **That** the data was obtained on representative units, randomly selected.

4. **That**, to the best of my knowledge and belief, the facts set forth in the application and accompanying technical data are true and correct.

Certifying Engineer: Morton Flom, P. Eng.